



## DESCRIPTION

The AM7520 is available in DFN8(3.3x3.3) package.

## ORDERING INFORMATION

Package Type	Part Number	
DFN8 (3.3x3.3)	J8	AM7520J8R
		AM7520J8VR
Note	V: Halogen free Package R: Tape & Reel SPQ: 3,000pcs/ Reel	
AiT provides all RoHS products Suffix " V " means Halogen free Package		

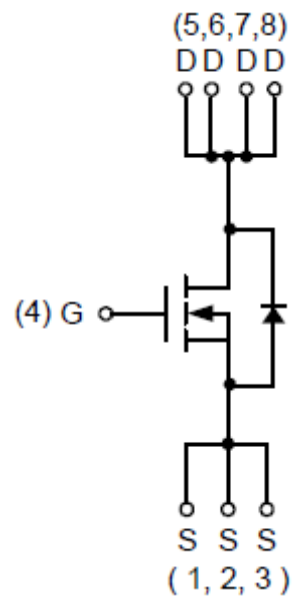
## FEATURES

- 30V/50A,  
 $R_{DS(ON)} = 1.8m\Omega(max.) @ V_{GS} = 10V$   
 $R_{DS(ON)} = 3.1m\Omega(max.) @ V_{GS} = 4.5V$
- 100% UIS +  $R_G$  Tested
- Avalanche Rated
- Reliable and Rugged
- Available in DFN8(3.3x3.3) package.

## APPLICATION

- Power Management in Notebook Computer, Portable Equipment and Battery Powered Systems.

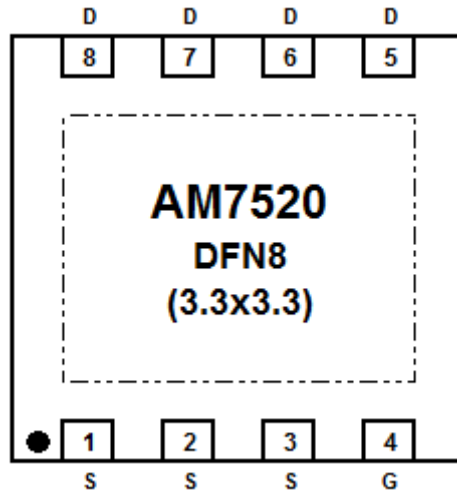
## PIN DESCRIPTION



N-Channel MOSFET



## PIN DESCRIPTION



Top View

Pin #	Symbol	Function
1	S	Source
2	S	Source
3	S	Source
4	G	Gate
5	D	Drain
6	D	Drain
7	D	Drain
8	D	Drain



## ABSOLUTE MAXIMUM RATINGS

$T_A = 25^\circ\text{C}$ , unless Otherwise Noted

$V_{DS}$ , Drain-Source Voltage		30V
$V_{GS}$ , Gate-Source Voltage		$\pm 20\text{V}$
$T_J$ , Maximum Junction Temperature		$150^\circ\text{C}$
$T_{STG}$ , Storage Temperature Range		$-55^\circ\text{C} \sim 150^\circ\text{C}$
$I_S$ , Diode Continuous Forward Current	$T_C=25^\circ\text{C}$	50A <sup>NOTE1</sup>
$I_D$ , Continuous Drain Current	$T_C=25^\circ\text{C}$	50A <sup>NOTE1</sup>
	$T_C=100^\circ\text{C}$	50A
$I_{DM}$ , Pulsed Drain Current	$T_C=25^\circ\text{C}$	200A <sup>NOTE2</sup>
$P_D$ , Maximum Power Dissipation	$T_C=25^\circ\text{C}$	62.5W
	$T_C=100^\circ\text{C}$	25W
$R_{\theta JC}$ , Thermal Resistance-Junction to Case	Steady State	$2^\circ\text{C/W}$
$I_D$ , Continuous Drain Current	$T_A=25^\circ\text{C}$	24A
	$T_A=70^\circ\text{C}$	19A
$P_D$ , Maximum Power Dissipation	$T_A=25^\circ\text{C}$	1.78W
	$T_A=70^\circ\text{C}$	1.14W
$R_{\theta JA}$ , Thermal Resistance-Junction to Ambient	$t \leq 10\text{s}$	$35^\circ\text{C/W}$
	Steady State <sup>NOTE3</sup>	$70^\circ\text{C/W}$
$I_{AS}$ <sup>NOTE4</sup> , Avalanche Current, Single Pulse	$L=0.1\text{mH}$	50A
$E_{AS}$ <sup>NOTE4</sup> , Avalanche Energy, Single Pulse	$L=0.1\text{mH}$	125mJ

Stress beyond above listed "Absolute Maximum Ratings" may lead permanent damage to the device. These are stress ratings only and operations of the device at these or any other conditions beyond those indicated in the operational sections of the specifications are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

NOTE1: Package is limited by 50A.

NOTE2: Pulse width is limited by maximum junction temperature.

NOTE3: Surface Mounted on  $1\text{in}^2$  pad area,  $t \leq 999\text{s}$ .

NOTE4: UIS tested and pulse width is limited by maximum junction temperature  $150^\circ\text{C}$  (initial temperature  $T_J = 25^\circ\text{C}$ ).



## ELECTRICAL CHARACTERISTICS

T<sub>A</sub> = 25°C, unless Otherwise Noted

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>DS</sub> =250μA	30	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V T <sub>J</sub> =85°C	-	-	1	μA
			-	-	30	
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250μA	1.4	1.7	2.5	V
Gate Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V	-	-	±100	nA
Drain-Source On-state Resistance	R <sub>DS(ON)</sub> NOTE5	V <sub>GS</sub> =10V, I <sub>DS</sub> =20A T <sub>J</sub> =125°C	-	1.5	1.8	mΩ
			-	2.3	-	
		V <sub>GS</sub> =4.5V, I <sub>DS</sub> =20A	-	2.3	3.1	
Forward Transconductance	G <sub>fs</sub>	V <sub>DS</sub> =5V, I <sub>DS</sub> =20A	-	25	-	S
<b>Diode Characteristics</b>						
Diode Forward Voltage	V <sub>SD</sub> NOTE5	I <sub>SD</sub> =20A, V <sub>GS</sub> =0V	-	0.8	1.1	V
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> =20A, di <sub>SD</sub> /dt=100A/μs	-	48.9	-	ns
Charge Time	t <sub>a</sub>		-	24.4	-	
Discharge Time	t <sub>b</sub>		-	24.5	-	
Reverse Recovery Charge	Q <sub>rr</sub>		-	42.8	-	
<b>Dynamic Characteristics</b> NOTE6						
Gate Resistance	R <sub>G</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, F=1MHz	-	1	-	Ω
Input Capacitance	C <sub>iSS</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, Frequency=1.0MHz	-	2883	-	pF
Output Capacitance	C <sub>oss</sub>		-	1857	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	125	-	
Turn-on Delay Time	t <sub>d(ON)</sub>	V <sub>DD</sub> =15V, R <sub>L</sub> =15Ω, I <sub>DS</sub> =1A, V <sub>GEN</sub> =10V, R <sub>G</sub> =6Ω	-	18	33	ns
Turn-on Rise Time	t <sub>r</sub>		-	10.7	20	
Turn-off Delay Time	t <sub>d(OFF)</sub>		-	48.3	88	
Turn-off Fall Time	t <sub>f</sub>		-	71.2	129	
<b>Gate Charge Characteristics</b> NOTE6						
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =15V, V <sub>GS</sub> =4.5V, I <sub>DS</sub> =20A	-	22	30.8	nC
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =15V, V <sub>GS</sub> =10V, I <sub>DS</sub> =20A	-	42.5	59.5	
Threshold Gate Charge	Q <sub>gth</sub>		-	6.4	9.0	
Gate-Source Charge	Q <sub>gs</sub>		-	10.6	14.8	
Gate-Drain Charge	Q <sub>gd</sub>	-	5.1	7.1		

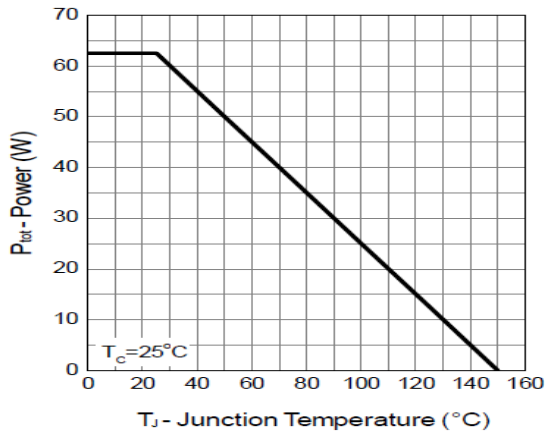
NOTE5: Pulse test; pulse width≤300μs, duty cycle≤2%.

NOTE 6: Guaranteed by design, not subject to production testing.

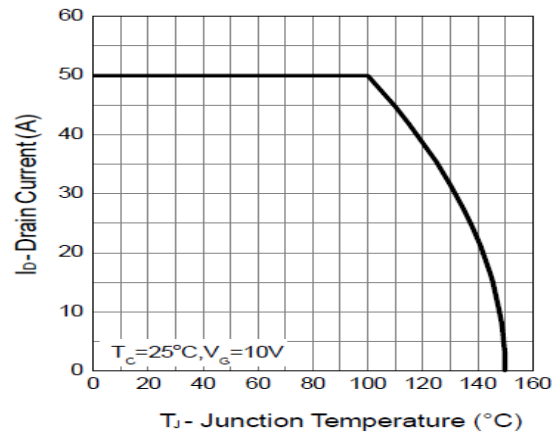


## TYPICAL PERFORMANCE CHARACTERISTICS

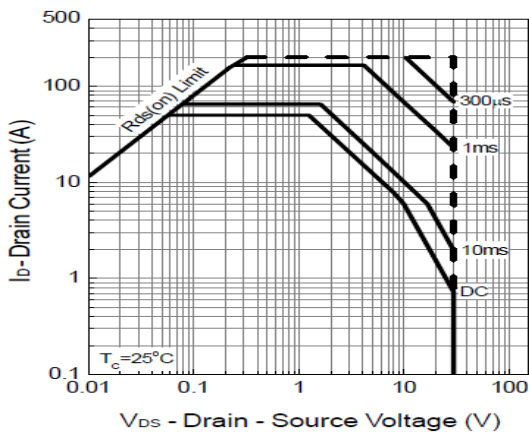
### 1. Power Dissipation



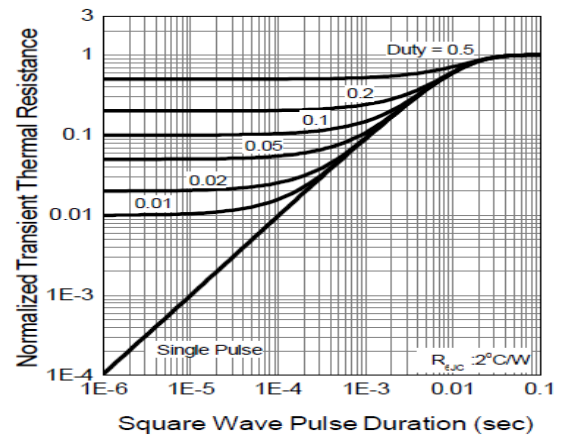
### 2. Drain Current



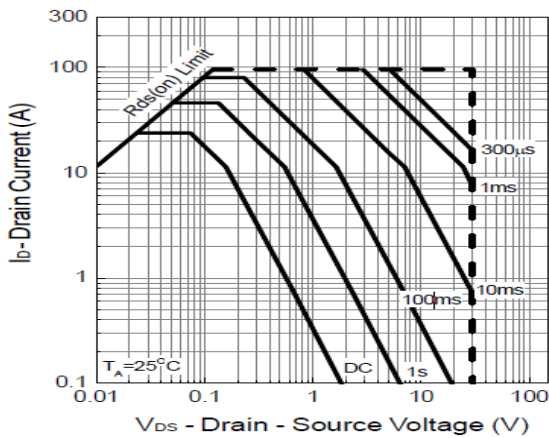
### 3. Safe Operation Area



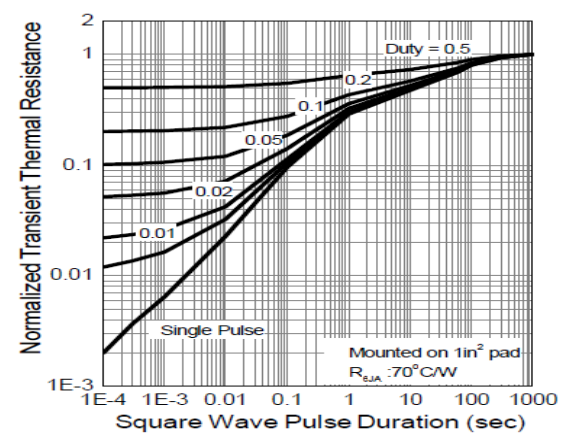
### 4. Thermal Transient Impedance



### 5. Safe Operation Area

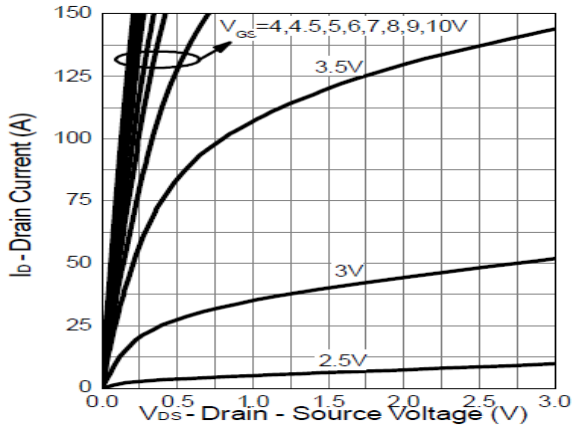


### 6. Thermal Transient Impedance

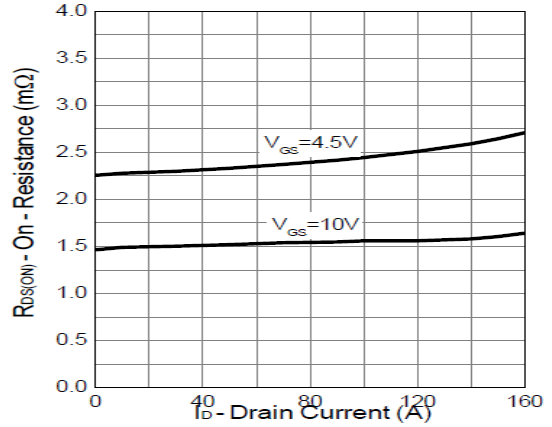




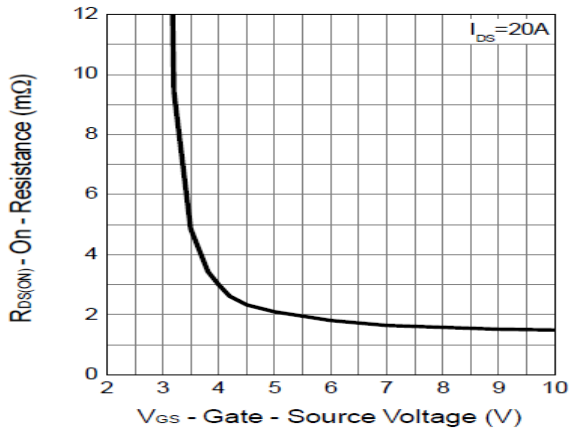
7. Output Characteristics



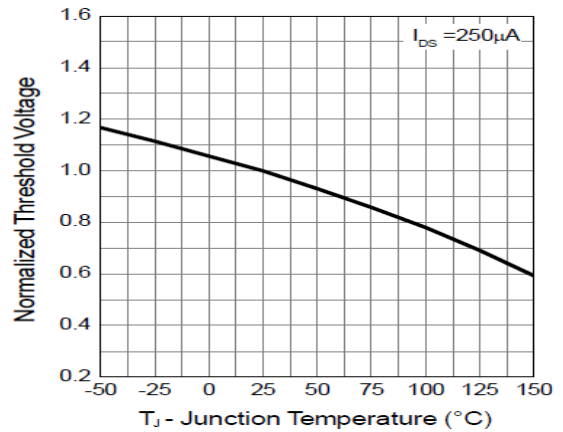
8. Drain-Source On Resistance



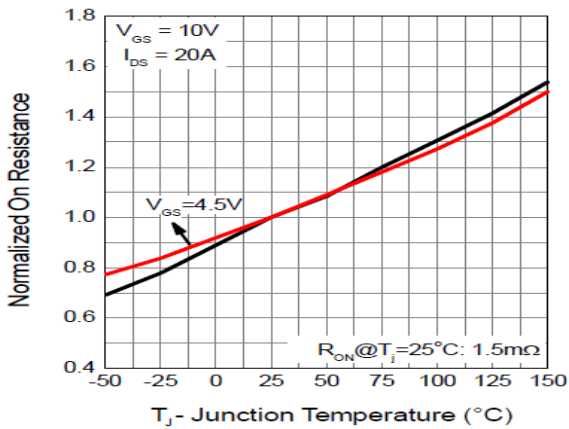
9. Gate-Source On Resistance



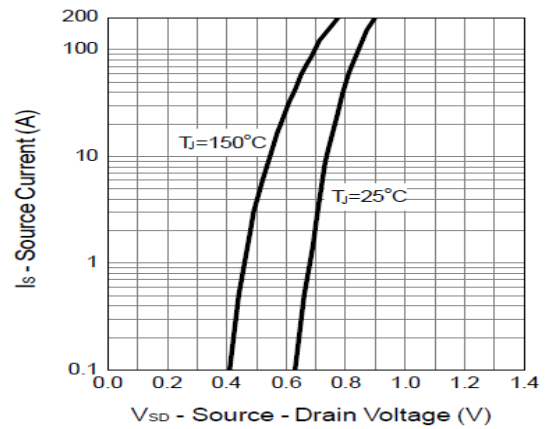
10. Gate Threshold Voltage



11. Drain-Source On Resistance

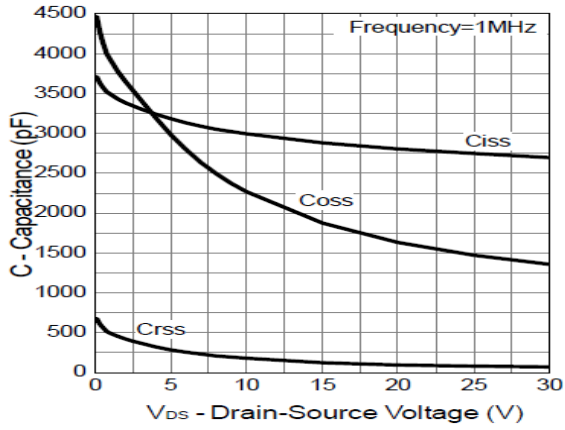


12. Source-Drain Diode Forward

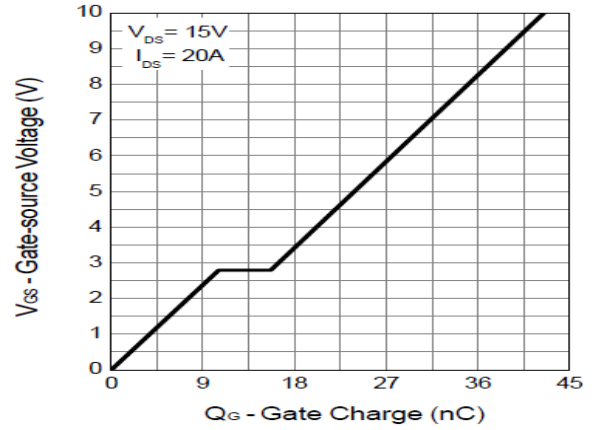




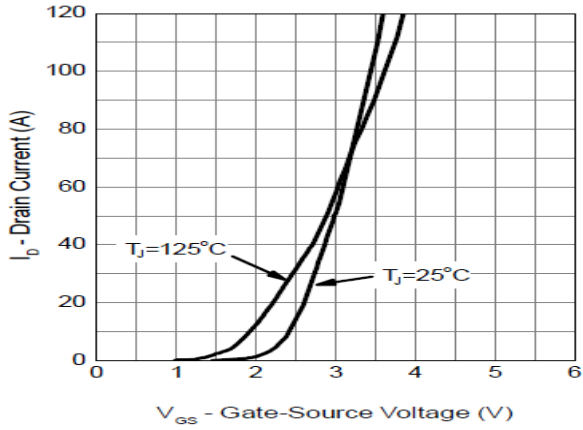
13. Capacitance



14. Gate Charge



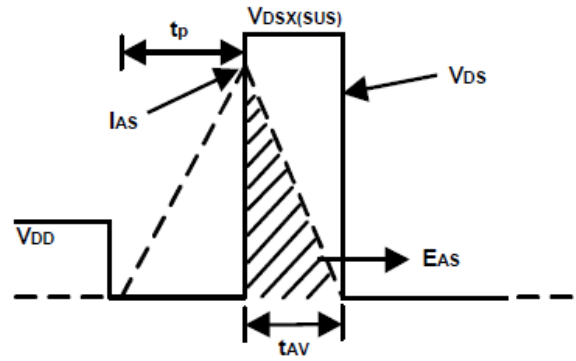
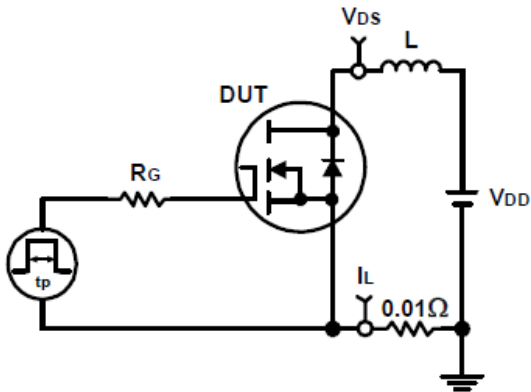
15. Transfer Characteristics



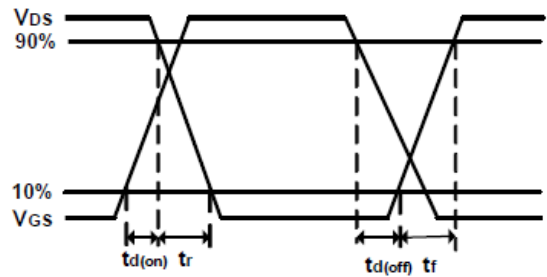
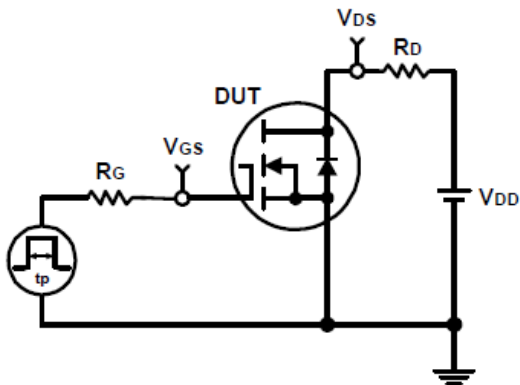


## DETAILED INFORMATION

### Avalanche Test Circuit and Waveforms



### Switching Time Test Circuit and Waveforms

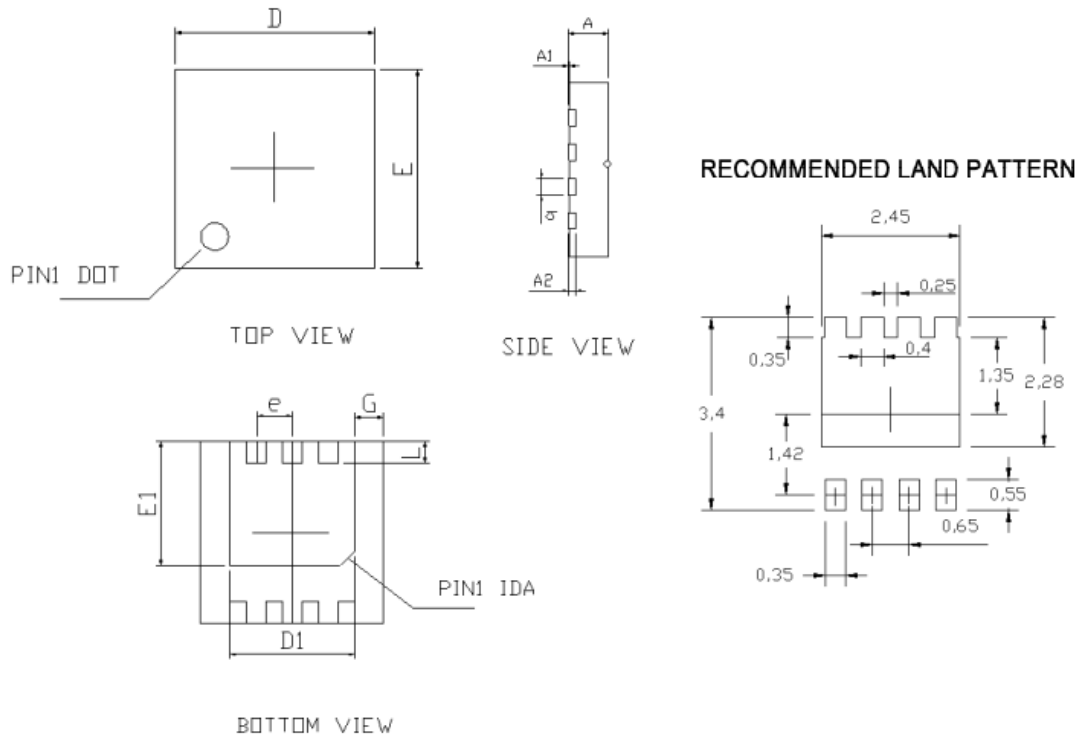






## PACKAGE INFORMATION

Dimension in DFN8 (Unit: mm)



Symbol	MILLIMETERS		INCHES	
	Min	Max	Min	Max
A	0.700	0.800	0.028	0.032
A1	0.000	0.050	0.000	0.002
A2	0.100	0.250	0.004	0.010
b	0.240	0.350	0.009	0.014
D	3.150	3.400	0.124	0.134
D1	2.100	2.350	0.083	0.093
E	3.150	3.400	0.124	0.134
E1	2.150	2.350	0.850	0.093
e	0.600	0.700	0.024	0.028
G	0.475	0.575	0.019	0.023
L	0.350	0.450	0.014	0.018



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